Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/792,027	TESSIER ET AL.	
Examiner	Art Unit	
Chan Wan Jiang	2744	

SEARCHED				
Class	Subclass	Date	Examiner	
62	51			
	94			
	47			
702	57 60			
	61 62			
	182 186			
	189			
700	286			
	291	9/21/2006	C1	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	I				
			i		

(INCLUDING SEARC	H STRATEGY)
	DATE	EXMR
EAST Searched Inventor Searched	9/21/2006	C1